Search Notes			

Application No.	Applicant(s)	
10/085,903	WEI ET AL.	
Examiner	Art Unit	
Heion Ming Loo	2823	

SEARCHED					
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH)
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EAST attached (USPAT, USPG, EPO, JPO, IBM, derwent)	2/23/2004	LEE
IEEE search attached	2/23/2004	LEE